Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/845,083	MANTEGNA ET AL.	
Examiner	Art Unit	
David Lazaro	2155	

	SEAR	CHED	
Class	Subclass	Date	Examiner
709	231, 246	10/3/2005	DRL
713	401, 503	10/3/2005	DRL
375	356, 371	10/3/2005	DRL
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INT	NTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST: USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB see history	10/11/2005	DRL	
NPL: ACM, Citeseer, Google, IEEE, INSPEC, IP.com Focus: skew, latency, delay, heuristic, temporal redundancy, resampling	10/3/2005	DRL	
PALM Inventor search	10/11/2005	DRL	